Search Notes



Application/Control No.	Applicant(s)/Patent Under	
	Reexamination	

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MARUYAMA ET AL.

Examiner

Art Unit

David Phantana-angkool

2175

SEARCHED

Class	Subclass	Date	Examiner
715	781, 783	4/8/2008	DP

CE	Λ	\sim 11	NIO	TES
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EAST-(see attached)	4/8/2008	DP

INTERFERENCE SEARCH

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